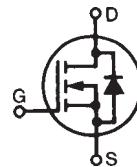


# High Voltage MOSFET

## IXTP05N100M

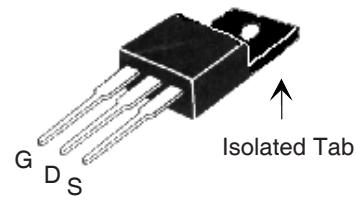
### (Electrically Isolated Tab)

N-Channel Enhancement Mode  
Avalanche Rated



$V_{DSS}$  = 1000V  
 $I_{D25}$  = 700mA  
 $R_{DS(on)}$  ≤ 17Ω

### OVERMOLDED TO-220 (IXTP...M) OUTLINE



G = Gate      D = Drain  
 S = Source

Symbol	Test Conditions	Maximum Ratings		
$V_{DSS}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$	1000		V
$V_{DGR}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$ , $R_{GS} = 1 \text{ M}\Omega$	1000		V
$V_{GSS}$	Continuous	$\pm 30$		V
$V_{GSM}$	Transient	$\pm 40$		V
$I_{D25}$	$T_C = 25^\circ\text{C}$	700		mA
$I_{DM}$	$T_C = 25^\circ\text{C}$ , pulse width limited by $T_{JM}$	3		A
$I_A$	$T_C = 25^\circ\text{C}$	1		A
$E_{AS}$	$T_C = 25^\circ\text{C}$	100		mJ
$dv/dt$	$I_S \leq I_{DM}$ , $V_{DD} \leq V_{DSS}$ , $T_J = 150^\circ\text{C}$	3		V/ns
$P_D$	$T_C = 25^\circ\text{C}$	25		W
$T_J$		-55 ... +150		°C
$T_{JM}$		150		°C
$T_{stg}$		-55 ... +150		°C
$T_L$	1.6 mm (0.062 in.) from case for 10 s	300		°C
$T_{SOLD}$	Plastic body for 10 s	260		°C
$M_d$	Mounting torque	1.13/10	Nm/lb.in.	
<b>Weight</b>		2.5		g

Symbol	Test Conditions ( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
$BV_{DSS}$	$V_{GS} = 0V$ , $I_D = 250\mu\text{A}$	1000		V
$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 25\mu\text{A}$	2.5		4.5 V
$I_{GSS}$	$V_{GS} = \pm 30V$ , $V_{DS} = 0V$			$\pm 100 \text{ nA}$
$I_{DSS}$	$V_{DS} = V_{DSS}$ $V_{GS} = 0V$			$25 \mu\text{A}$ $500 \mu\text{A}$
$R_{DS(on)}$	$V_{GS} = 10V$ , $I_D = 375\text{mA}$ , Note 1	15	17	Ω

### Features

- Plastic overmolded tab for electrical isolation
- International standard package
- Avalanche rated
- Low package inductance
  - easy to drive and to protect

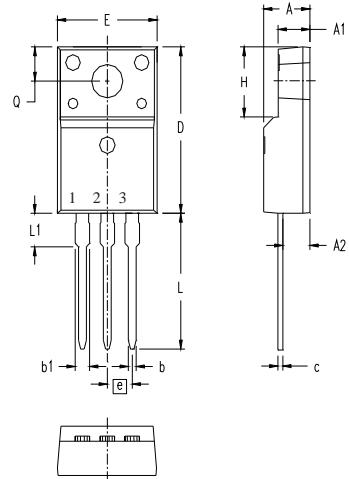
### Advantages

- Easy to mount
- Space savings
- High power density

Symbol	Test Conditions	Characteristic Values		
		( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	Min.	Typ.
$g_{fs}$	$V_{DS} = 20\text{V}$ , $I_D = 500\text{mA}$ , Note 1	0.55	0.93	S
$C_{iss}$		260		pF
$C_{oss}$	$V_{GS} = 0\text{V}$ , $V_{DS} = 25\text{V}$ , $f = 1\text{MHz}$	22		pF
$C_{rss}$		8		pF
$t_{d(on)}$	<b>Resistive Switching Times</b> $V_{GS} = 10\text{V}$ , $V_{DS} = 0.5 \cdot V_{DSS}$ , $I_D = 1\text{A}$ $R_G = 47\Omega$ (External)	11		ns
$t_r$		19		ns
$t_{d(off)}$		40		ns
$t_f$		28		ns
$Q_{g(on)}$		7.8		nC
$Q_{gs}$	$V_{GS} = 10\text{V}$ , $V_{DS} = 0.5 \cdot V_{DSS}$ , $I_D = 1\text{A}$	1.4		nC
$Q_{gd}$		4.1		nC
$R_{thJC}$			5.0	$^\circ\text{C}/\text{W}$

**Source-Drain Diode****Characteristic Values** $(T_J = 25^\circ\text{C}$  unless otherwise specified)

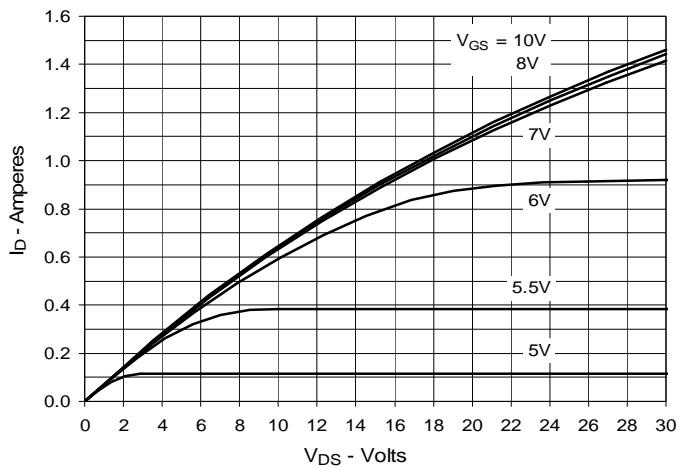
Symbol	Test Conditions	Characteristic Values		
		Min.	Typ.	Max.
$I_s$	$V_{GS} = 0\text{V}$		750	mA
$I_{SM}$	Repetitive, pulse width limited by $T_{JM}$		3	A
$V_{SD}$	$I_F = I_S$ , $V_{GS} = 0\text{V}$ , Note 1		1.5	V
$t_{rr}$	$I_F = 750\text{mA}$ , $-di/dt = 100\text{A}/\mu\text{s}$ , $V_R = 100\text{V}$ , $V_{GS} = 0\text{V}$	710		ns

Notes:1. Pulse test,  $t \leq 300 \mu\text{s}$ ; duty cycle,  $d \leq 2\%$ .**ISOLATED TO-220 (IXTP...M)**

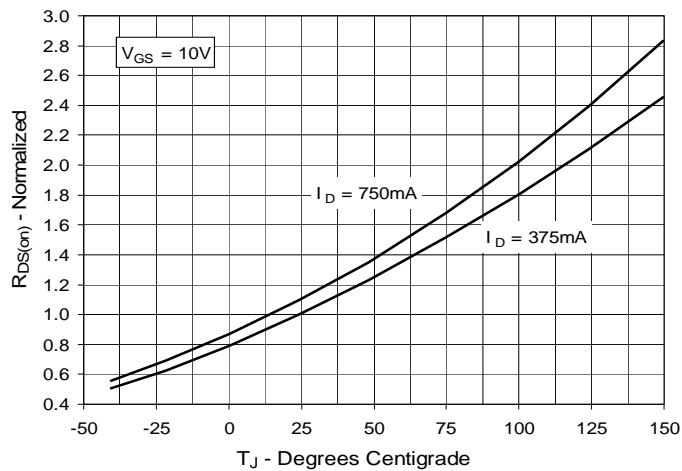
Terminals: 1 - Gate  
2 - Drain (Collector)  
3 - Source (Emitter)

SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.177	.193	4.50	4.90
A1	.092	.108	2.34	2.74
A2	.101	.117	2.56	2.96
b	.028	.035	0.70	0.90
b1	.050	.058	1.27	1.47
c	.018	.024	0.45	0.60
D	.617	.633	15.67	16.07
E	.392	.408	9.96	10.36
e	.100	BSC	2.54	BSC
H	.255	.271	6.48	6.88
L	.499	.523	12.68	13.28
L1	.119	.135	3.03	3.43
ØP	.121	.129	3.08	3.28
Q	.126	.134	3.20	3.40

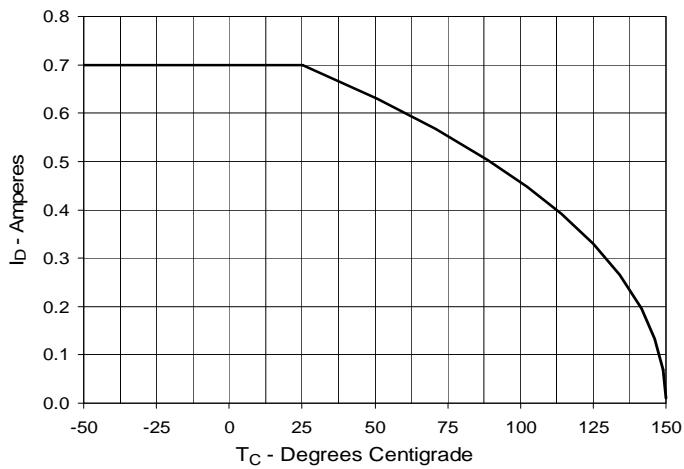
**Fig. 1. Output Characteristics  
@ 25°C**



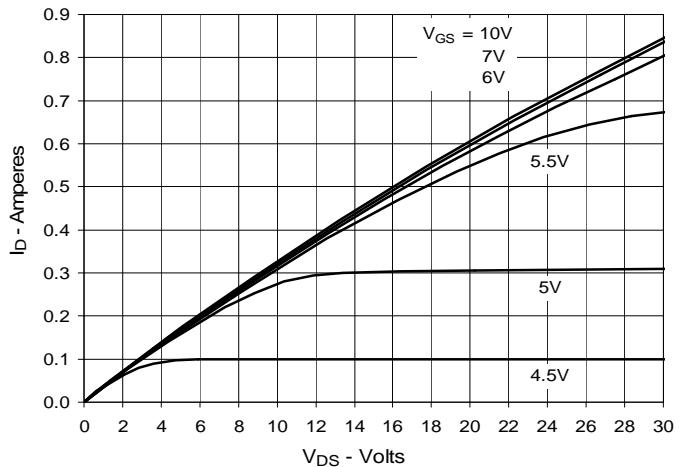
**Fig. 3.  $R_{DS(on)}$  Normalized to  $I_D = 375\text{mA}$   
Value vs. Junction Temperature**



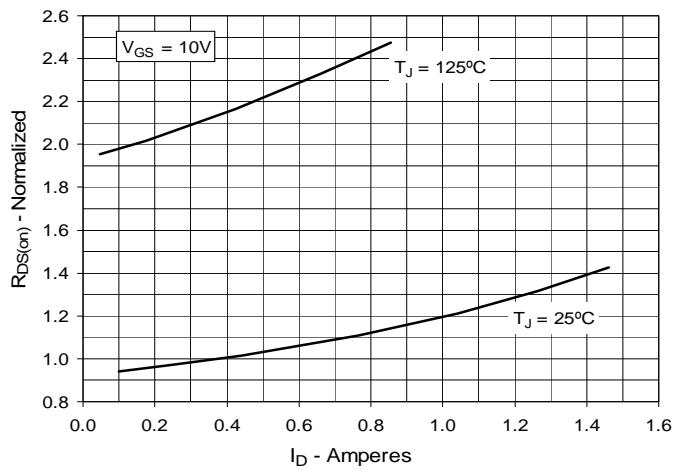
**Fig. 5. Maximum Drain Current vs.  
Case Temperature**



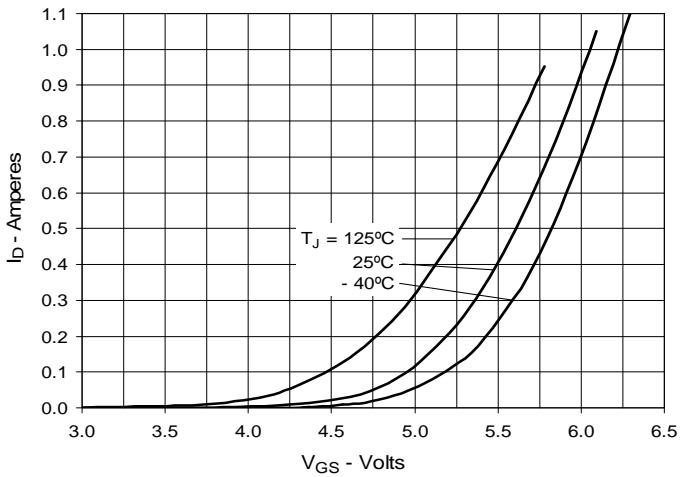
**Fig. 2. Output Characteristics  
@ 125°C**

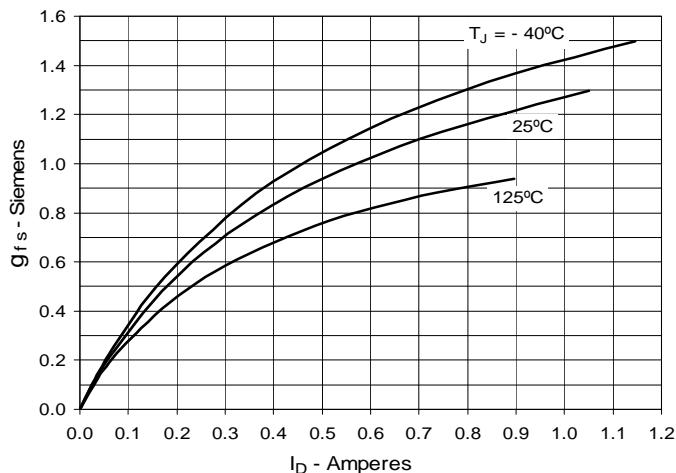
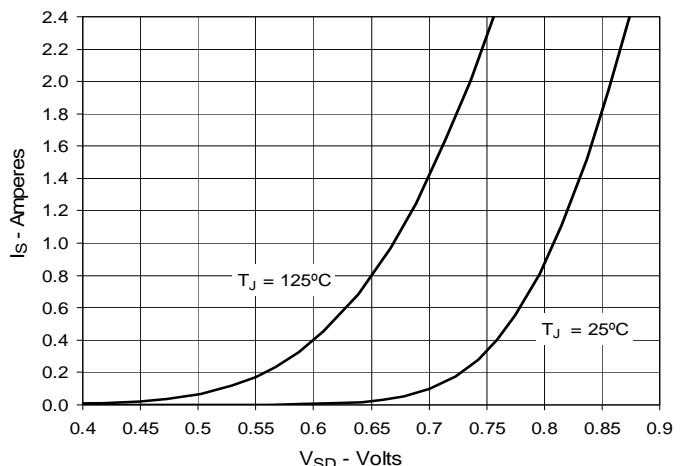
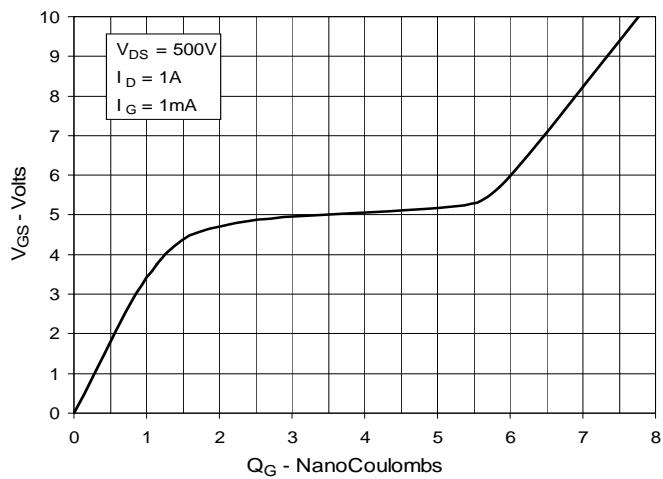
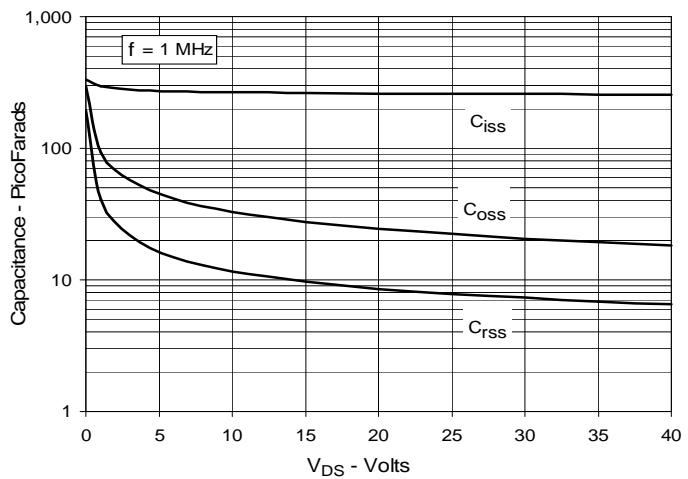
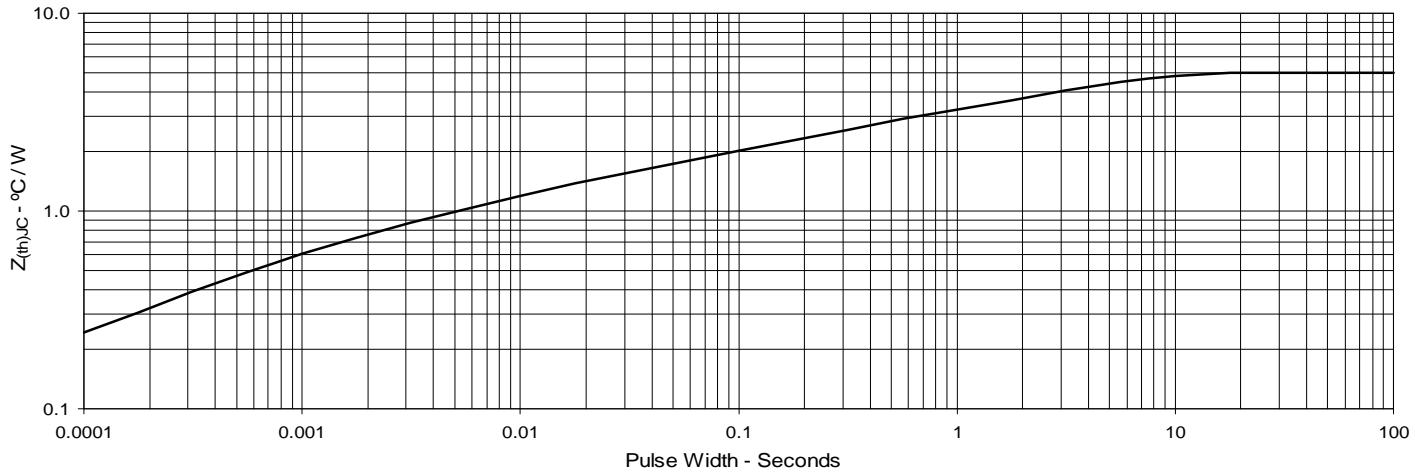


**Fig. 4.  $R_{DS(on)}$  Normalized to  $I_D = 375\text{mA}$   
Value vs. Drain Current**



**Fig. 6. Input Admittance**



**Fig. 7. Transconductance****Fig. 8. Forward Voltage Drop of Intrinsic Diode****Fig. 9. Gate Charge****Fig. 10. Capacitance****Fig. 11. Maximum Transient Thermal Impedance**

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